

<b>Notice of References Cited</b>	Application/Control No. 10/722,233	Applicant(s)/Patent Under Reexamination KAJINO, TSUTOMU	
	Examiner Lan Nguyen	Art Unit 3683	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,512,447	04-1985	Miura, leaki	188/282.6
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	DE 19615587 A1	10-1997	Germany	GRUNDEI et al.	F16F 09/34
	O	JP 11082597 A	03-1999	Japan	MIYAZAWA, SEIJI	F16F 09/348
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.